

**Notice of References Cited**

Application/Control No.

10/725,514

Applicant(s)/Patent Under  
Reexamination  
HEENEY ET AL.

Examiner

Shean C. Wu

Art Unit

1795

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	CAPLUS 1992: 42166
	V	Ruiz et al., "Repeat Unit Symmetry Effects on the Physical and Electronic Properties of Processable, Electrically Conducting, SUBstituted Poly(1,4-bis(2-thienyl)phenylene)", Macromolecules 1992, 25 page 849-860
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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